- · Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

#### description

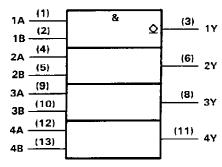
These devices contain four independent 2-input AND gates. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher VOH levels.

The SN5409, SN54LS09, and SN54S09 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7409, SN74LS09, and SN74S09 are characterized for operation from 0°C to 70°C.

#### FUNCTION TABLE (each gate)

INP	UTS	OUTPUT
А	В	Y
Н	Н	H
L	Х	L
x	L	L

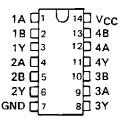
#### logic symbol



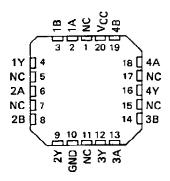
<sup>†</sup>This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

SN5409, SN54LS09, SN54S09 . . . J OR W PACKAGE SN7409 . . . N PACKAGE SN74LS09, SN74S09 . . . D OR N PACKAGE (TOP VIEW)

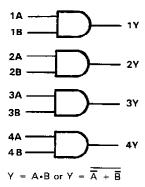


SN54LS09, SN54S09 . . . FK PACKAGE (TOP VIEW)

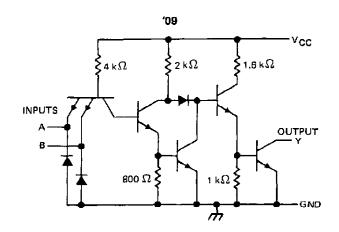


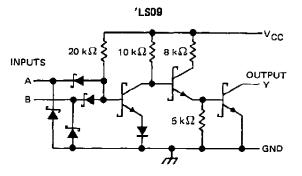
NC-No internal connection

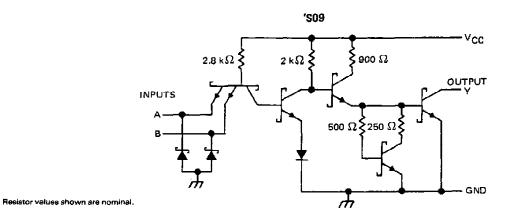
#### logic diagram (positive logic)



#### schematics (each gate)







#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, Vcc (see Note 1)		7 V
'LS09	***************************************	7 V
Operating free-air temperature range:	: SN54'	55°C to 125°C
	SN74'	
Storage temperature range		65°C to 150°C

NOTE 1; Voltage values are with respect to network ground terminal.

## SN5409, SN7409 QUADRUPLE 2 INPUT POSITIVE AND GATES WITH OPEN-COLLECTOR OUTPUTS

#### recommended operating conditions

	SN5409				UNIT		
	MIN	NOM	MAX	MIN	NOM	MAX	DIVIT
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	<b>v</b>
V <sub>IH</sub> High-level input voltage	2			2			>
V <sub>IL</sub> Low-level input voltage			0.8			8.0	V
V <sub>OH</sub> High-level output voltage			5.5			5.5	٧
IOL Low-level output current			16			16	mΑ
TA Operating free-air temperature	- 55		125	O		70	°C

#### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS!	MIN TYP\$ MAX	UNIT
VIK	VCC = MIN,	I <sub>I</sub> = - 12 mA	- 1,5	V
(он	V <sub>CC</sub> - MIN,	V <sub>1H</sub> = 2 V, V <sub>OH</sub> = 5,5 V	0.25	mA
VOL	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = 0.8 V I <sub>OL</sub> = 16 mA	0.2 0.4	٧
lj.	VCC = MAX,	V <sub>j</sub> = 5.5 V	1	mΑ
Чн	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.4 V	40	μД
liL.	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 0.4 V	- 1.6	mA
ГССН	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 4.5 V	11 21	mА
ICCL	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0 V	20 33	mA

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

### switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	ŢΥP	MAX	UNIT
tPLH			0.045.05		21	32	ns
tPHL	A or B	Y	$H_L = 400 \Omega$ , $C_L = 15  pF$		16	24	пѕ

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

# SN54LS09, SN74LS09 QUADRUPLE 2-INPUT POSITIVE-AND GATES WITH OPEN-COLLECTOR OUTPUTS

#### recommended operating conditions

	] ;	SN54LS09			SN74LS09			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC Supply voltage	4.5	5	5.5	4.75	5	5.25	٧	
V <sub>IH</sub> High-level input voltage	2			2			٧	
VIL Low-level input voltage			0.7			8.0	٧	
VOH High-level output voltage			5.5			5.5	٧	
IOL Low-level output current			4			8	mΑ	
TA Operating free-air temperature	<b>– 55</b>		125	0		70	°C	

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

*******		TEST CONDITIONS †		-	SN54LS	109	,	SN74LS	:09	UNIT
PARAMETER		TEST CONDITIONS	MIN	TYP‡	MAX	MIN	TYP\$	MAX	UNII	
VIK	V <sub>CC</sub> = MIN,	lı = — 18 mA				- 1.5			- 1.5	٧
юн	V <sub>CC</sub> = MIN,	V <sub>IH</sub> = 2 V,	V <sub>OH</sub> = 5.5 V			0.1			0.1	mΑ
V.	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = MAX,	IOL = 4 mA		0.25	0.4		0.25	0.4	
VOL	VCC = MIN,	VIL = MAX,	I <sub>OL</sub> = 8 mA				· · · · · · · · · · · · · · · · · · ·	0.35	0.5	0.5 V
11	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 7 V				0.1			0.1	mA
Чн	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V				20			20	μА
IIL.	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 0.4 V	· · · · · · · · · · · · · · · · · · ·			- 0.4	***		- 0.4	mA
Іссн	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 4.5 V			2.4	4.8		2.4	4.8	mA
<sup> </sup> CCL	V <sub>CC</sub> = MAX,	V  = 0 V	-		4,4	8.8		4.4	8.8	mΑ

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

### switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO {QUTPUT}	TEST CON	NDITIONS	MIN	TYP	MAX	UNIT
t <sub>PLH</sub>	A or B	v	$R_1 = 2 k\Omega$ ,	C <sub>f</sub> = 15 pF		20	35	ns
₹PHL	7, 5, 5	,	11[ - 2 838,	OE - 19 bi		17	35	กร

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

<sup>‡</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_{A}$  = 25°C.

# SN54S09, SN74S09 QUADRUPLE 2-INPUT POSITIVE-AND GATES WITH OPEN-COLLECTOR OUTPUTS

#### recommended operating conditions

		SN54S0	54S09 S		SN74S0	LINUT	
	MIN	NOM	MAX	MIN	NOM	MAX	TINU
V <sub>CC</sub> Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V <sub>1H</sub> High-level input voltage	2			2			٧
V <sub>IL</sub> Low-level input voltage			0.8			0.8	V
VOH High-level output voltage			5.5	_		5.5	٧
IOL Low-level output current			20			20	mA
TA Operating free-air temperature	- 55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	MIN TYP# MAX	TINU
ViK	V <sub>CC</sub> = MIN,	i <sub>1</sub> = - 18 mA	-1.2	V
ГОН	VCC = MIN,	V <sub>IH</sub> = 2 V, V <sub>OH</sub> = 5,5 V	0.25	mA
Vol	V <sub>CC</sub> = MIN,	V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 20 mA	0.5	V
lj.	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 5.5 V	1	mA
<sup>1</sup> ін	V <sub>CC</sub> = MAX,	V <sub>1</sub> = 2.7 V	50	μА
ll L	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0.5 V	-2	mA
1 <sub>ССН</sub>	V <sub>CC</sub> = MAX,	V <sub> </sub> = 4.5 V	18 32	mA
ICCL	V <sub>CC</sub> = MAX,	V <sub>I</sub> = 0 V	32 57	mΑ

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, $V_{CC} = 5 \text{ V}$ , $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	MIN TYP	MAX	UNIT	
<sup>t</sup> PLH			P 290 O	C <sub>I</sub> = 15 pF	6.5	10	ns
<sup>t</sup> PHL	A or B		R <sub>L</sub> = 280 Ω,  R <sub>L</sub> = 280 Ω,	C[ - 15 pr	6.5	10	ns
<sup>Į</sup> PLH	AUFB	Ι ΄ Γ		C: = 50.05	9		ns
<sup>t</sup> PHL				C <sub>L</sub> = 50 pF	9		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

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